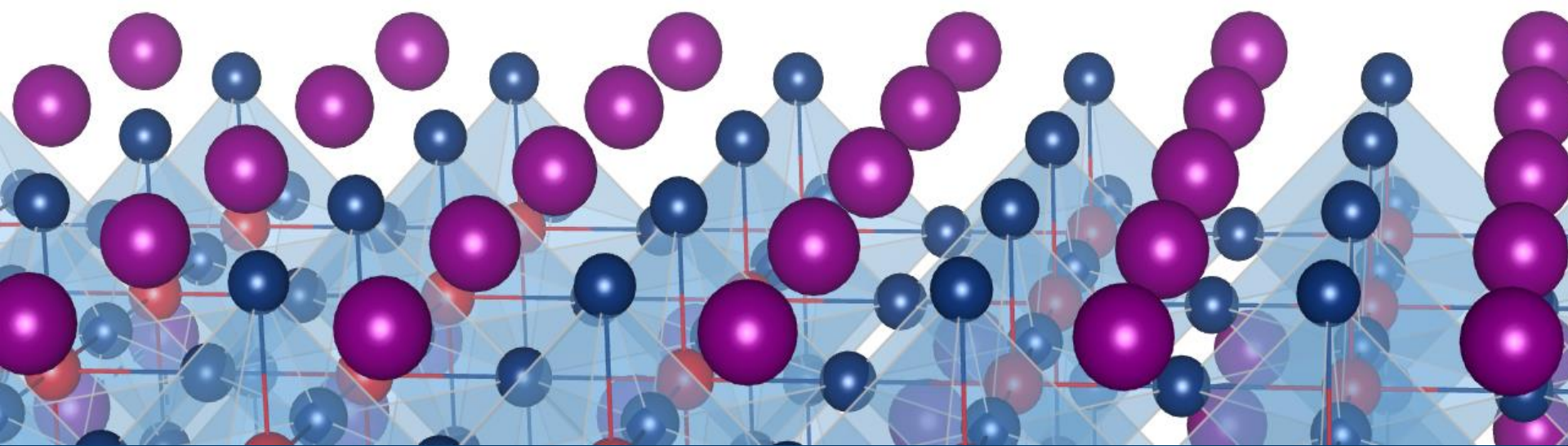




RECOMBINATION AND THE CONCEPT OF CHARGE CARRIER LIFETIMES IN LEAD-HALIDE PEROVSKITES

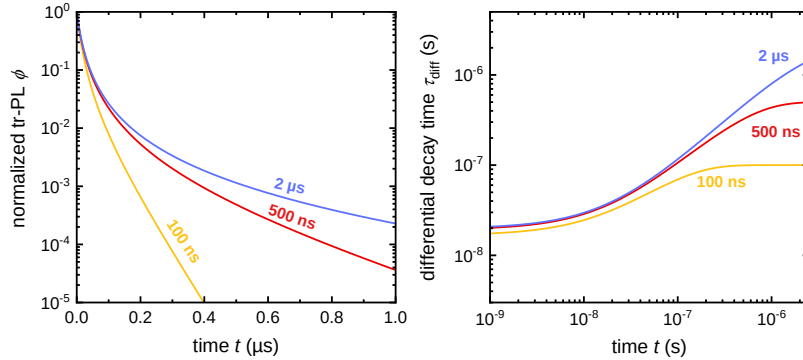
Thomas Kirchartz^{1,2}, Lisa Krückemeier¹, Zhifa Liu¹, Uwe Rau¹

¹IEK-5 Photovoltaik, Forschungszentrum Jülich,

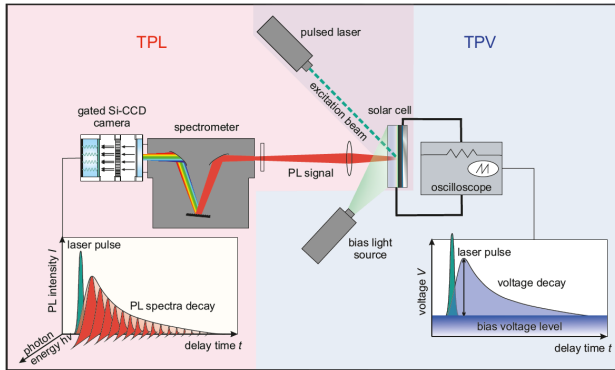
²NST and CENIDE, Universität Duisburg-Essen

Outline

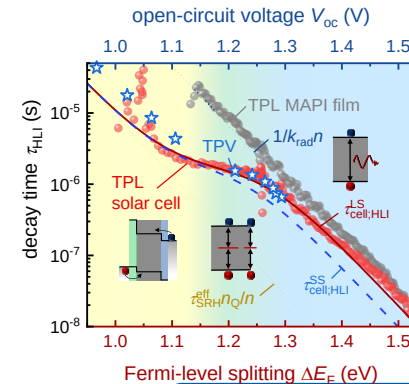
- 1) What is a charge carrier “lifetime”?
- 2) Why is it important?



3) How do I measure it on different sample types?



4) How to interpret the data?



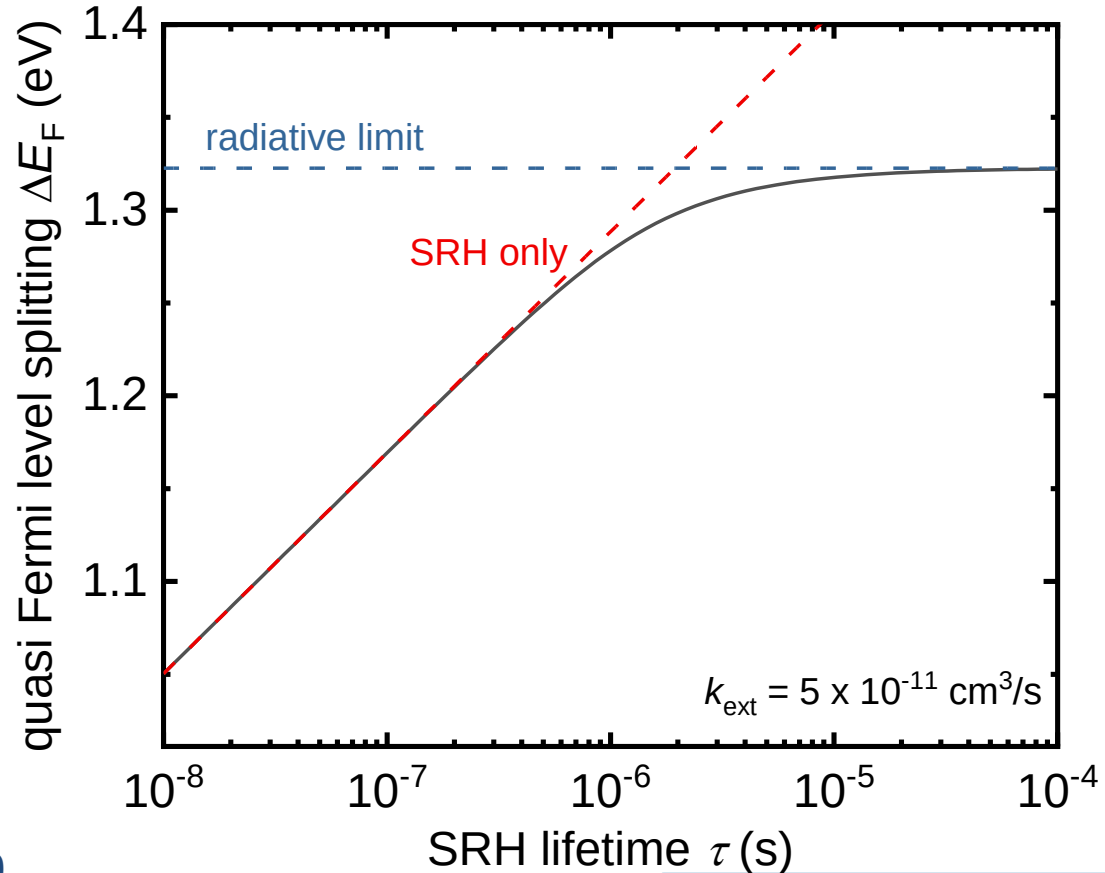
Why are charge carrier lifetimes relevant?

@ open circuit

$$G = kn^2 + \frac{n}{\tau}$$

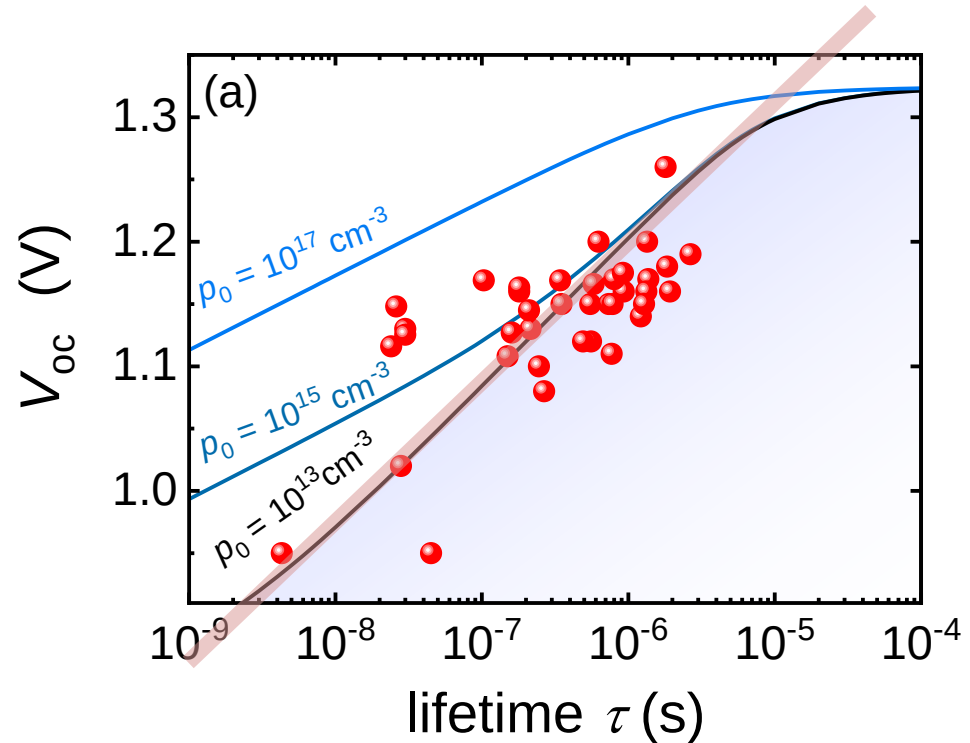
lifetime

$$\Delta E_F = kT \ln \left(\frac{n^2}{n_i^2} \right)$$



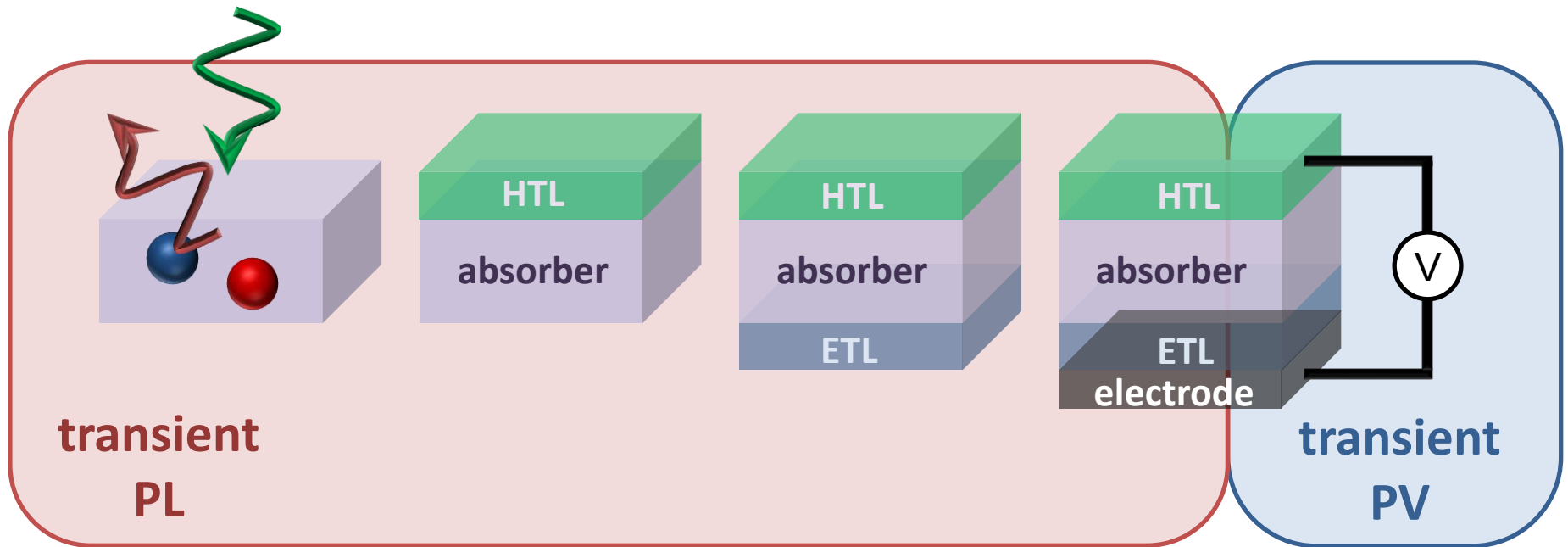
Why things are more difficult in reality than in theory?

$$\Delta E_F = 2kT \ln \left(\frac{G\tau}{n_i} \right)$$



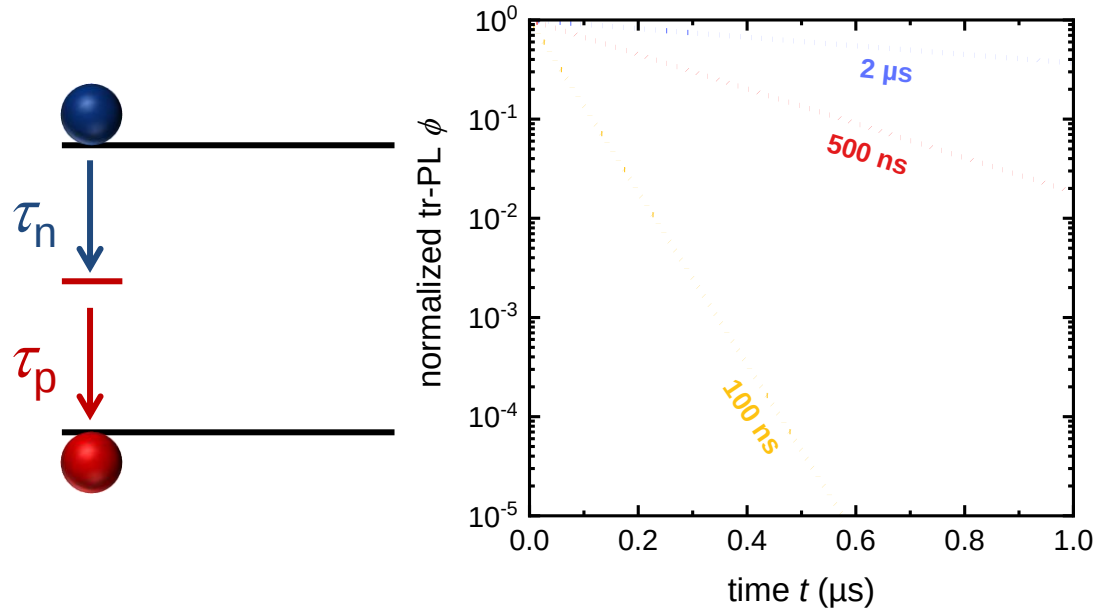
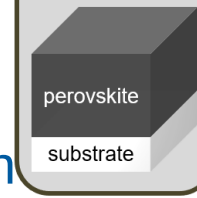
How can transient methods help...

...to study recombination and voltage losses



Transient Photoluminescence

Layer on Glass – SRH Recombination



$$n = p$$

$$\frac{dn}{dt} = -\frac{np}{\tau_p n + \tau_n p} = -\frac{n}{\tau_p + \tau_n} = -\frac{n}{\tau_{\text{SRH}}}$$

$$n(t) = n(0) \exp(-t / \tau_{\text{SRH}})$$

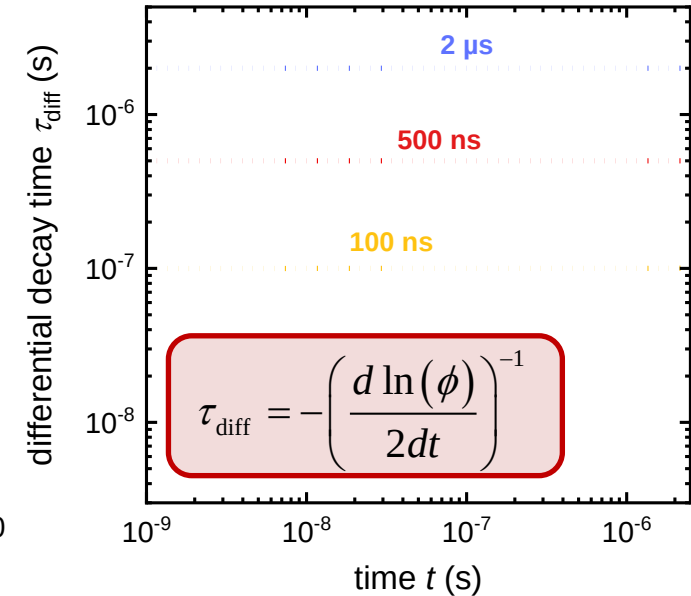
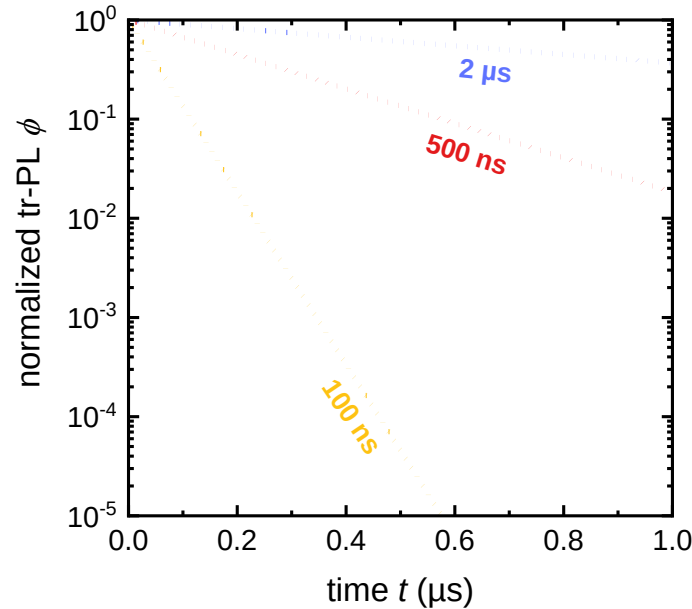
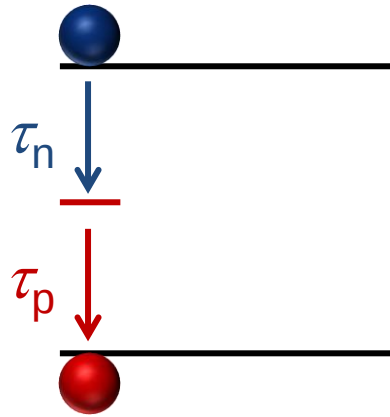
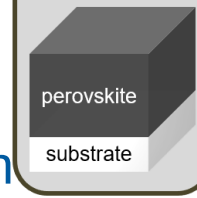
$$PL(t) \propto n^2(t) \propto \exp(-2t / \tau_{\text{SRH}})$$

$$\frac{dn}{dt} = -\frac{np}{\tau_p n + \tau_n p}$$

Shockley-Read-Hall (SRH) recombination only

Transient Photoluminescence

Layer on Glass – SRH Recombination

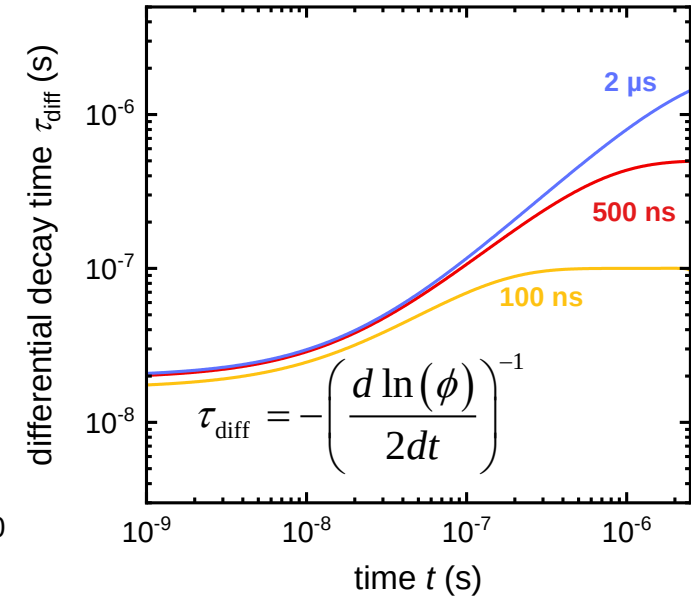
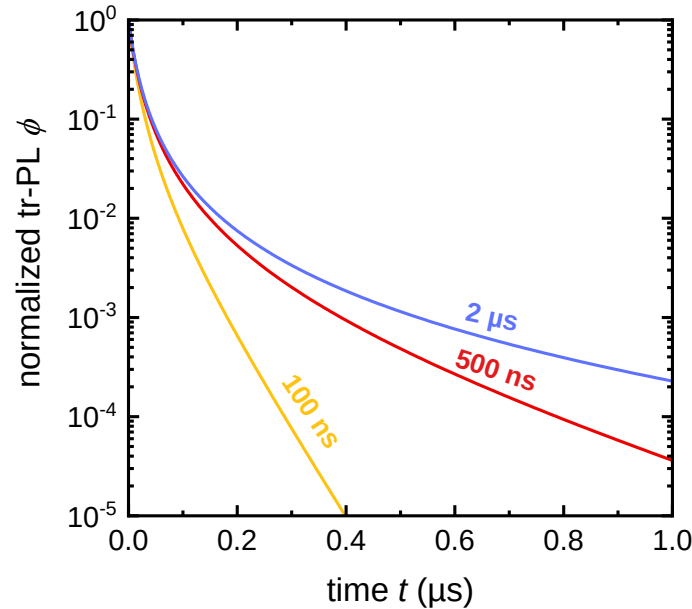
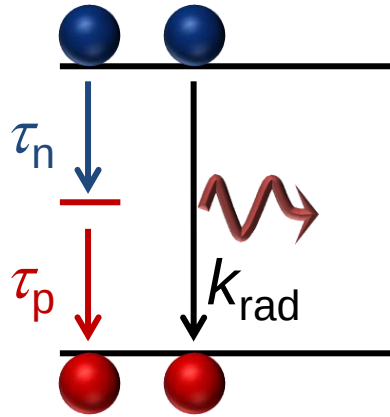
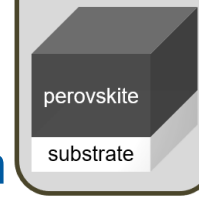


$$\frac{dn}{dt} = -\frac{np}{\tau_p n + \tau_n p}$$

Shockley-Read-Hall (SRH) recombination only

Transient Photoluminescence

Layer on Glass – Bulk Recombination

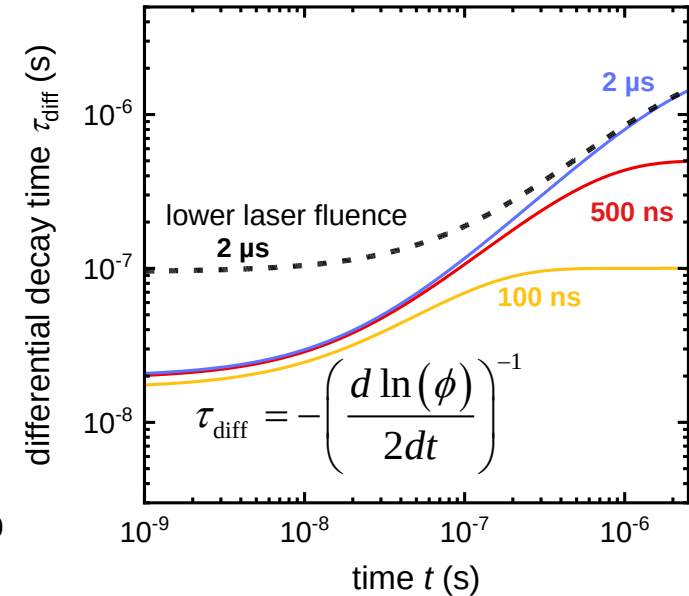
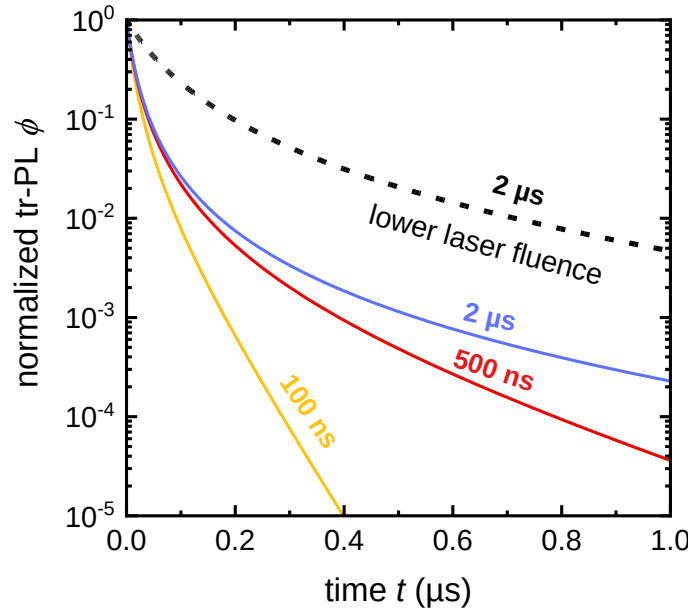
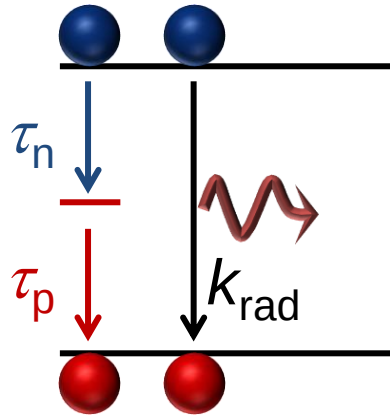
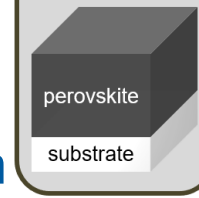


$$\frac{dn}{dt} = -k_{\text{rad}}np - \frac{np}{\tau_p n + \tau_n p}$$

SRH + radiative recombination

Transient Photoluminescence

Layer on Glass – Bulk Recombination

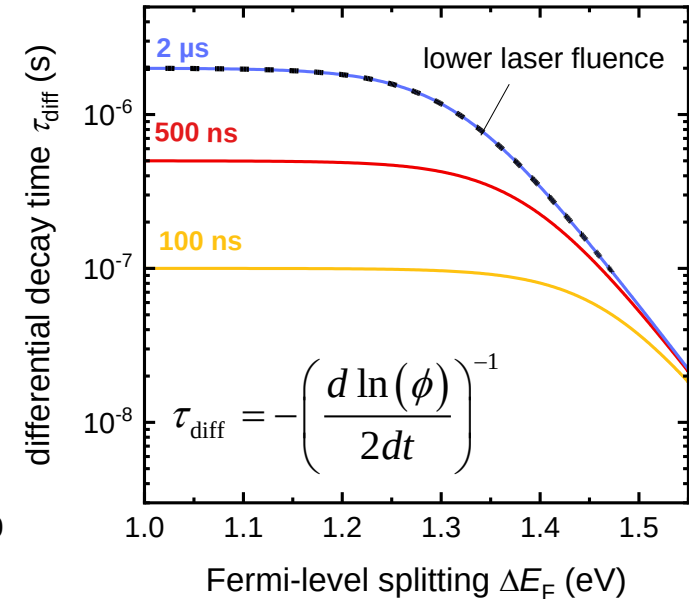
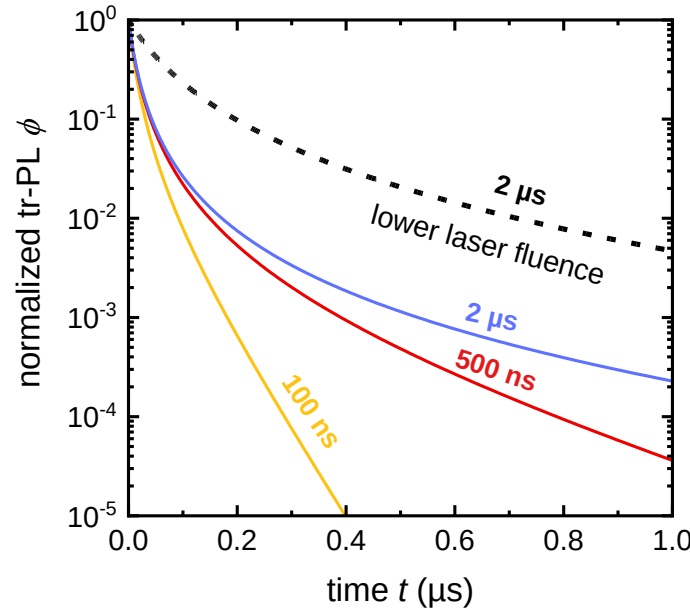
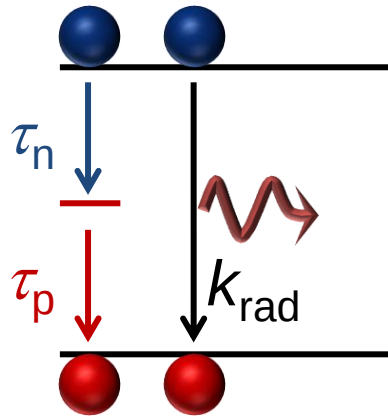
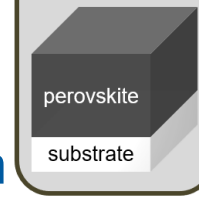


$$\frac{dn}{dt} = -k_{\text{rad}}np - \frac{np}{\tau_p n + \tau_n p}$$

SRH + radiative recombination

Transient Photoluminescence

Layer on Glass – Bulk Recombination

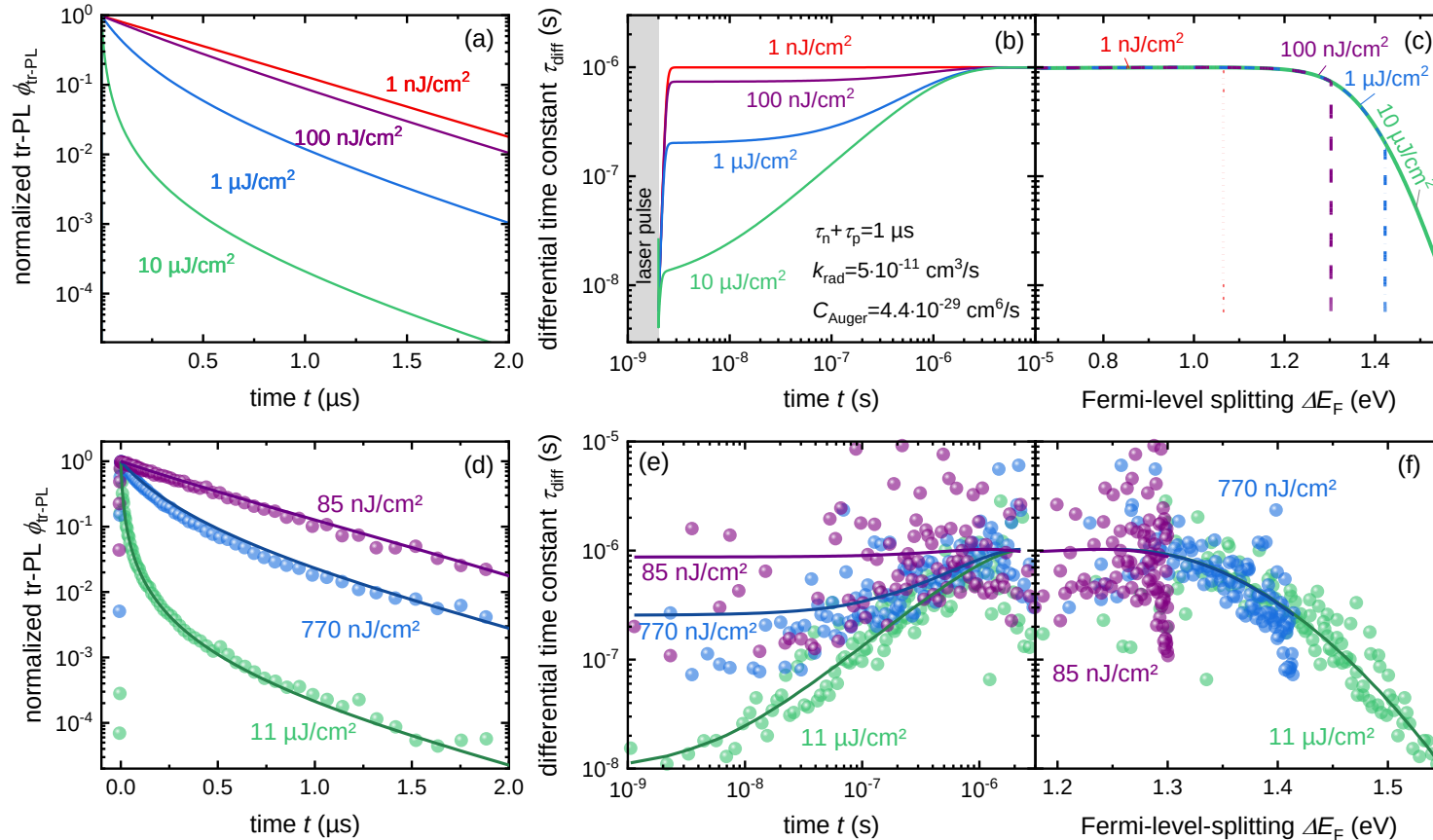


$$\frac{dn}{dt} = -k_{\text{rad}}np - \frac{np}{\tau_p n + \tau_n p}$$

SRH + radiative recombination

← time

From time axis to QFLS axis

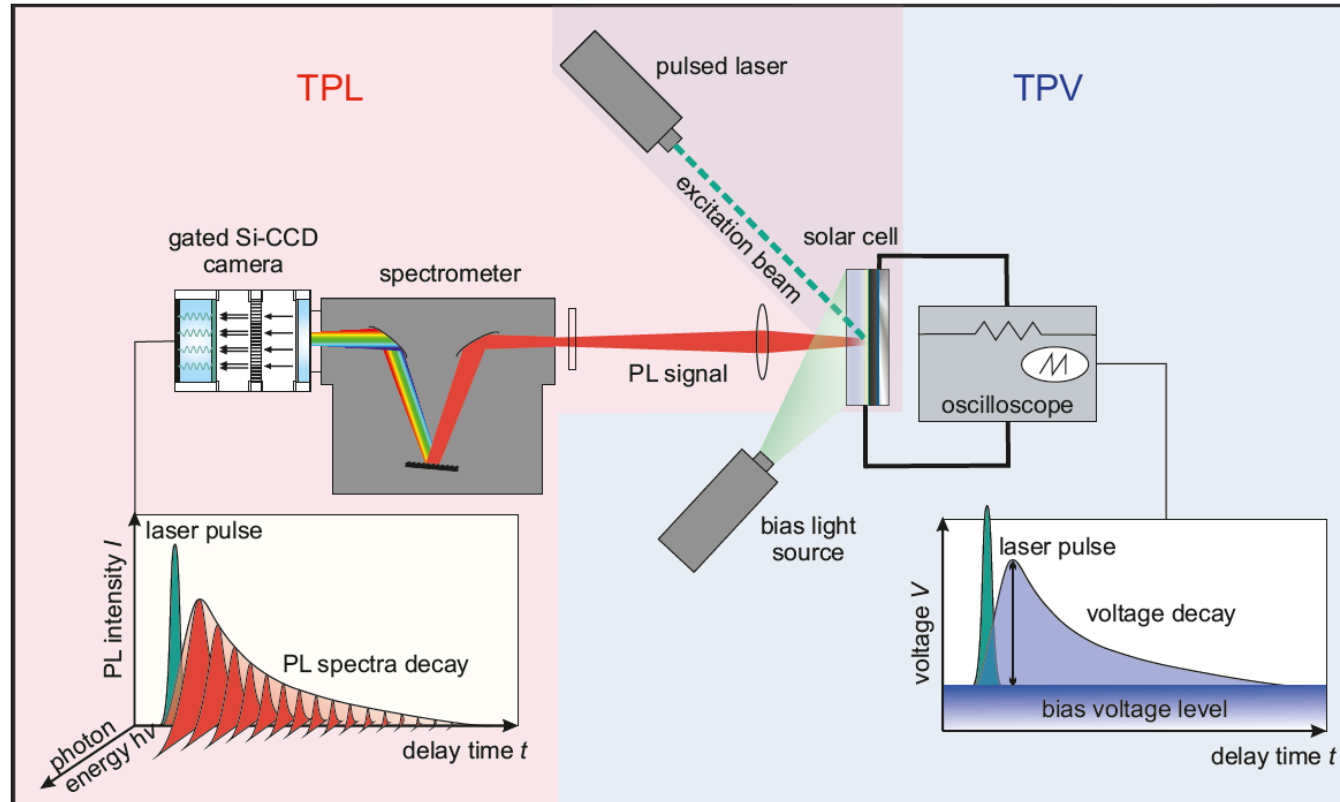


Transient Photoluminescence (TPL)

measures the luminescence decay

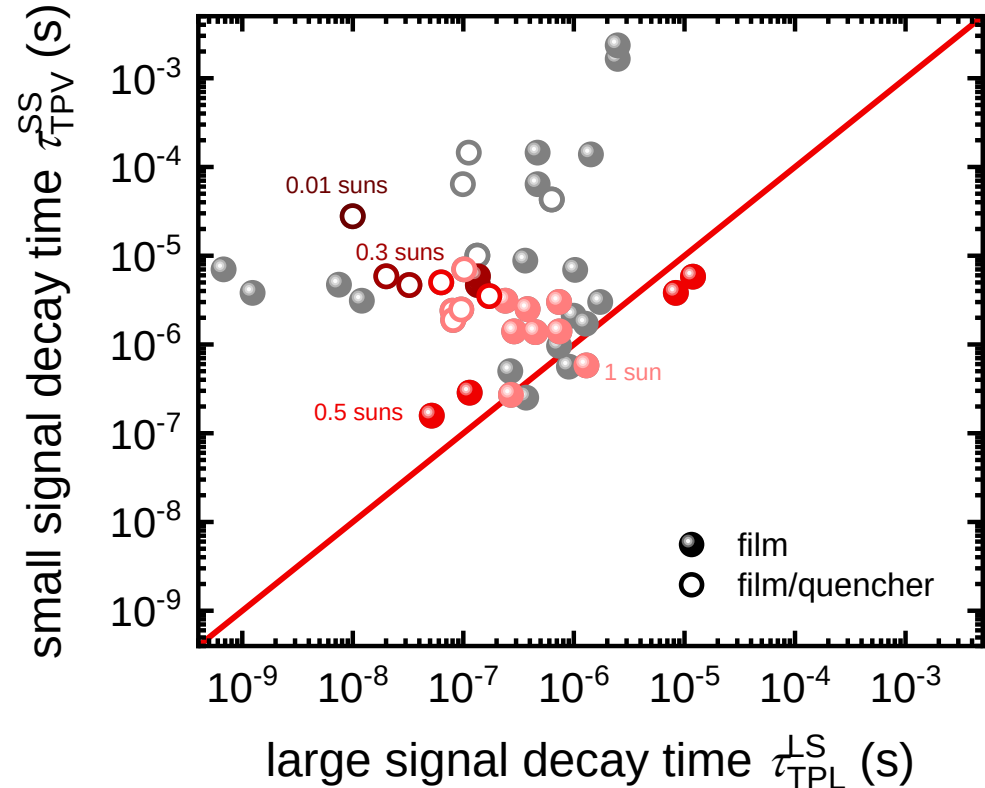
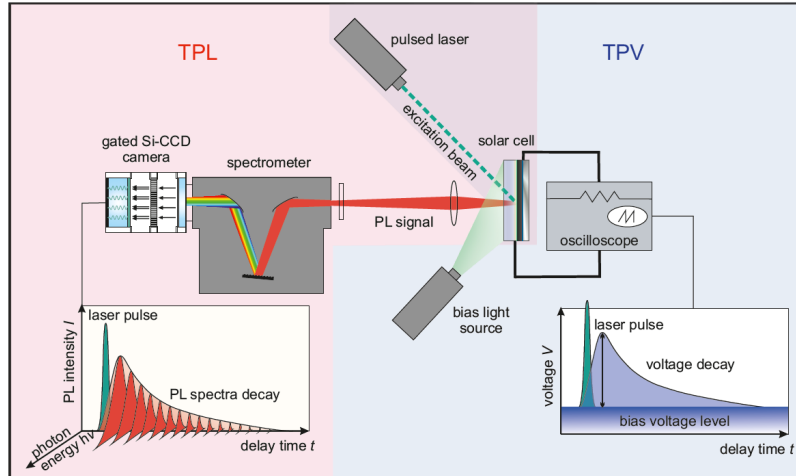
Transient Photovoltage (TPV)

measures the decay of an external voltage



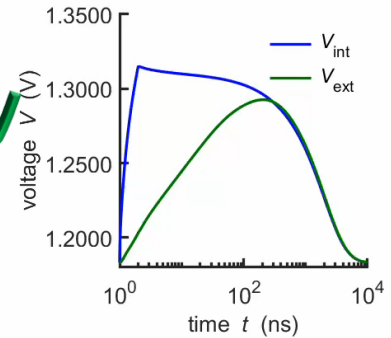
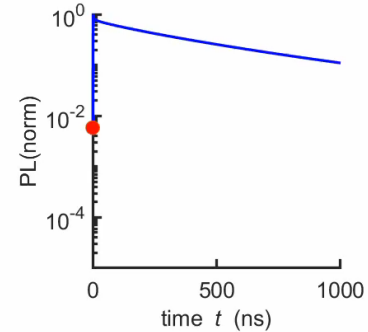
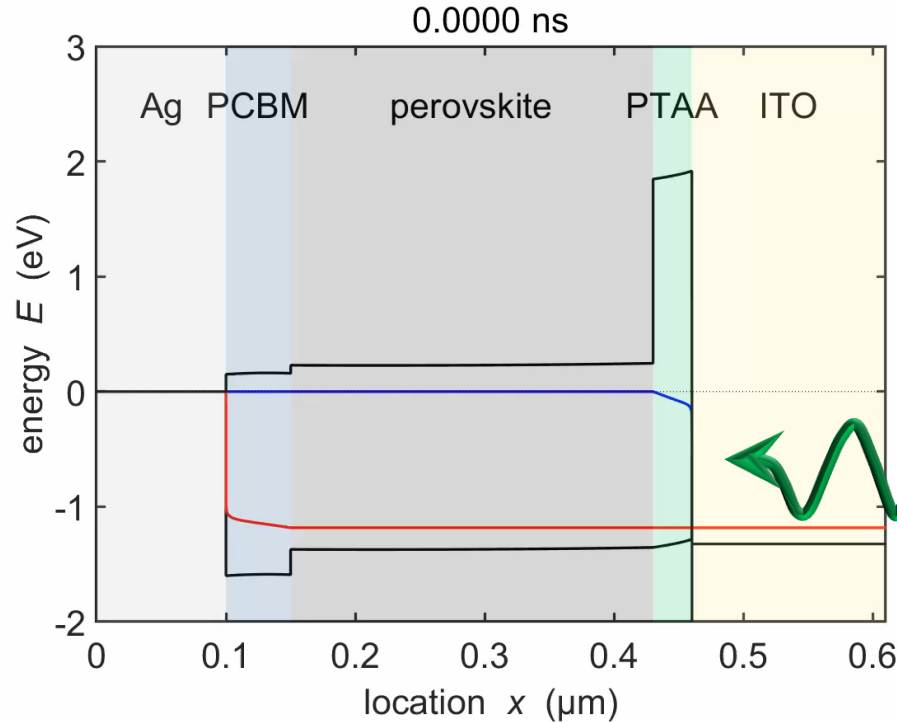
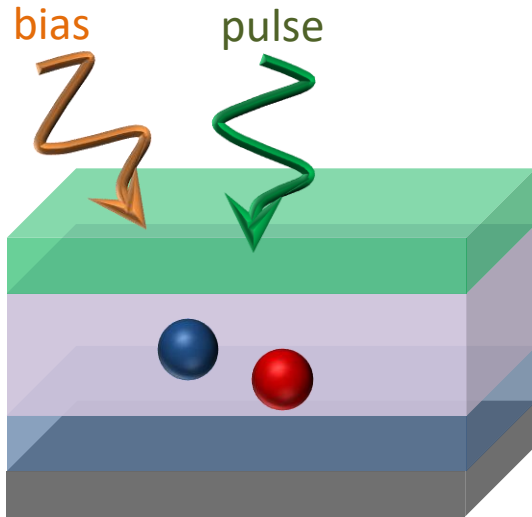
Metaanalysis: TPV vs. TPL

Fairly poor correlation between the two decay times. Why?

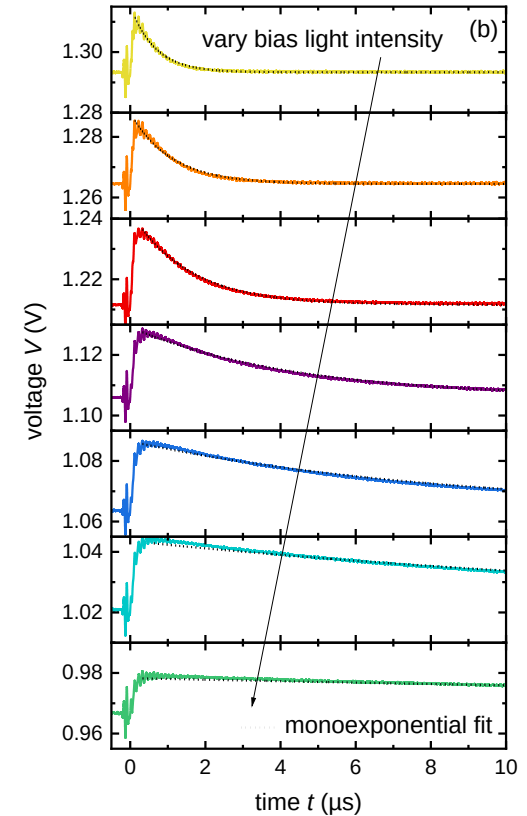
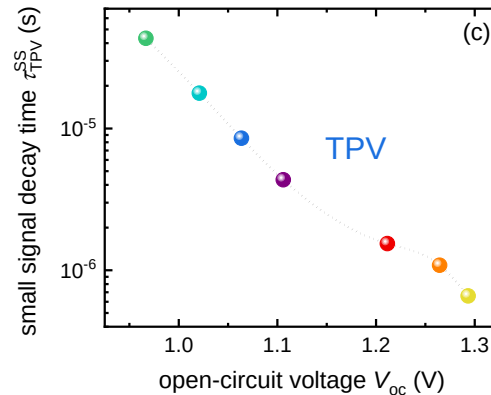
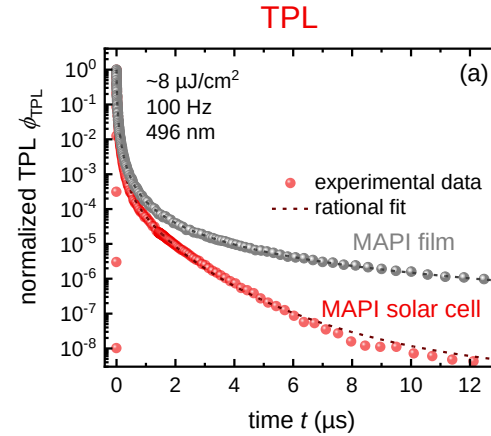
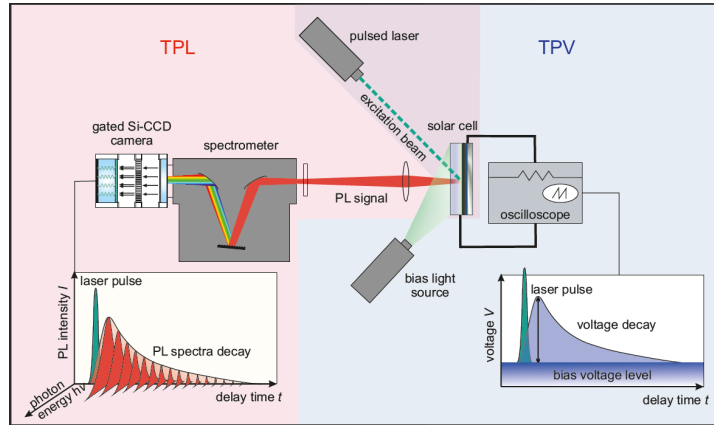


Transients with bias light

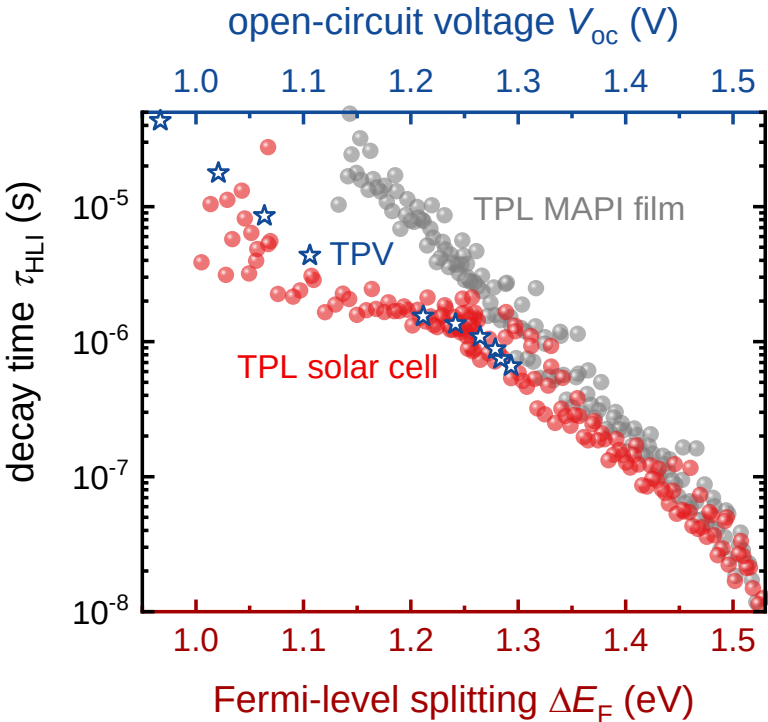
Video TPV vs. TPL



What is typically measured?



How to make sense out of it

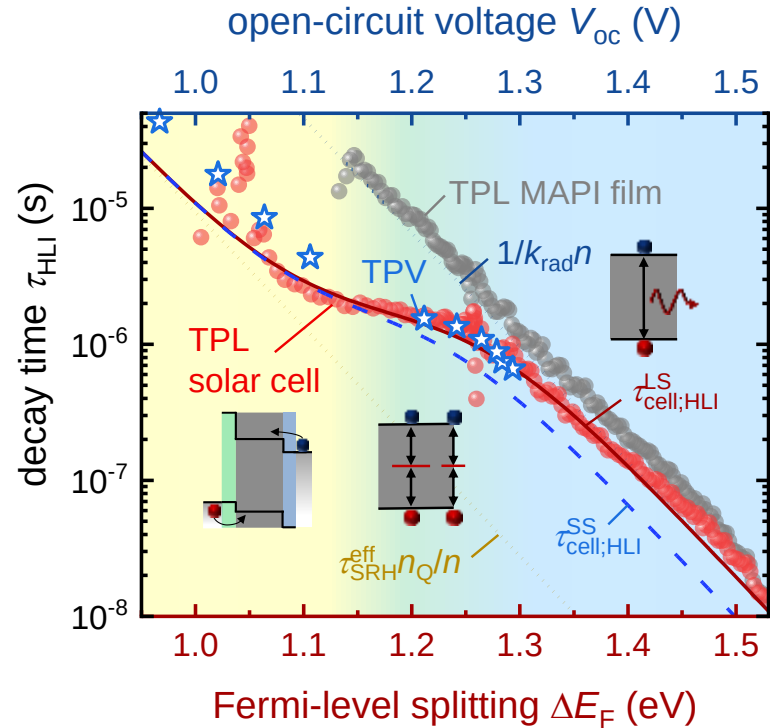


$$\frac{dn(t)}{dt} = -k_{\text{rad}} n(t)^2 - \frac{n(t)}{\tau_{\text{SRH}}^{\text{bulk}}} - \frac{C_{\text{area}}}{qd_{\text{pero}}} \frac{dV_{\text{ext}}(t)}{dt} + G$$

$$\tau_{\text{cell, HLI}}^{\text{LS}} = -\frac{n(t)}{dn(t)/dt} = \frac{n_Q/n(t) + 1}{k_{\text{rad}} n(t) + 1/\tau_{\text{SRH}}^{\text{eff}}}$$

$$n_Q = 2C_{\text{area}} k_B T / (q^2 d_{\text{pero}})$$

How to make sense out of it



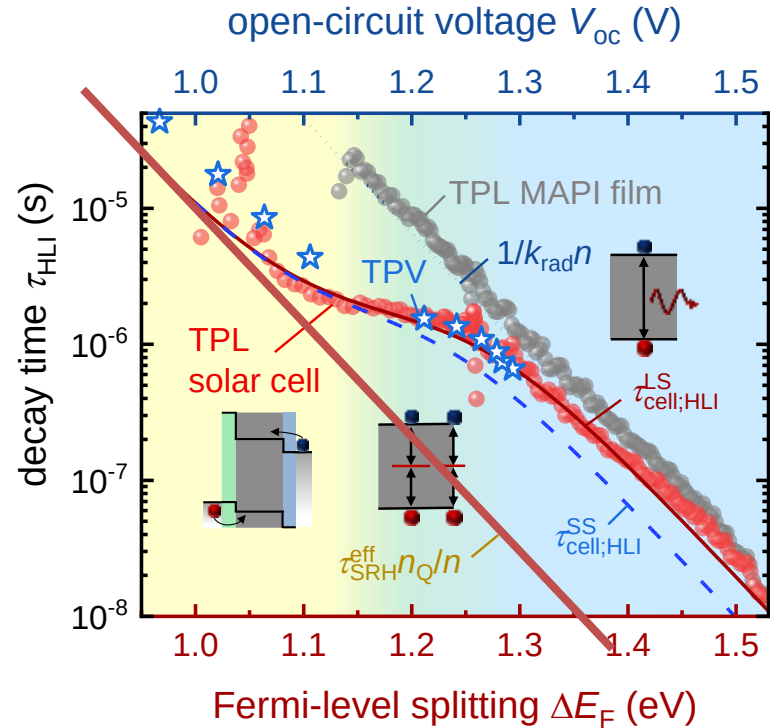
Capacitive charging of the electrodes

$$\frac{dn(t)}{dt} = -k_{rad}n(t)^2 - \frac{n(t)}{\tau_{SRH}^{bulk}} - \left[\frac{C_{area}}{qd_{pero}} \frac{dV_{ext}(t)}{dt} \right] + G$$

$$\tau_{cell, HLI}^{LS} = -\frac{n(t)}{dn(t)/dt} = \frac{n_Q/n(t) + 1}{k_{rad}n(t) + 1/\tau_{SRH}^{eff}}$$

$$n_Q = 2C_{area}k_B T / (q^2 d_{pero})$$

How to make sense out of it

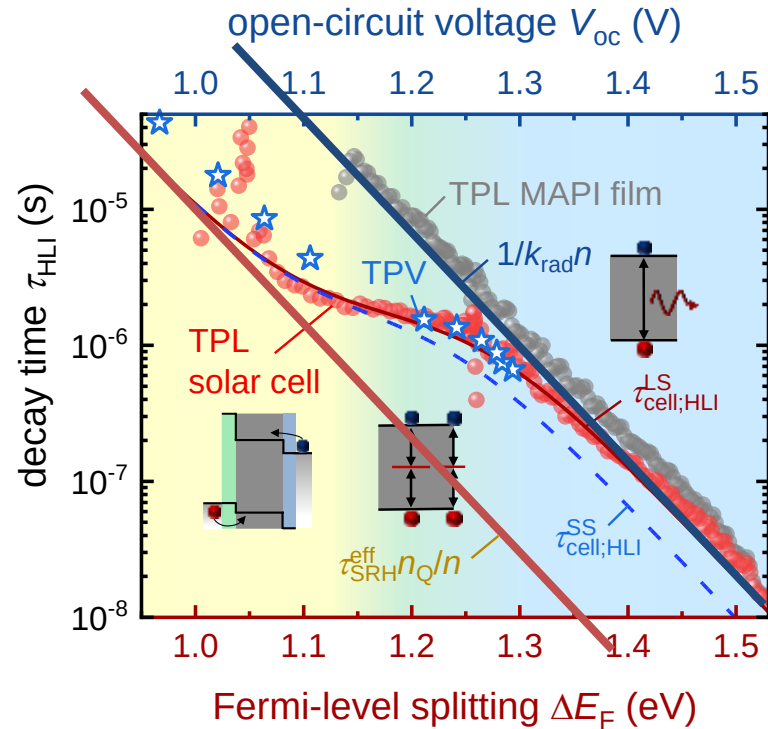


$$\frac{dn(t)}{dt} = -k_{rad}n(t)^2 - \frac{n(t)}{\tau_{SRH}^{bulk}} - \frac{C_{area}}{qd_{pero}} \frac{dV_{ext}(t)}{dt} + G$$

$$\tau_{cell, HLI}^{LS} = -\frac{n(t)}{dn(t)/dt} = \frac{n_Q/n(t)+1}{k_{rad}n(t)+1/\tau_{SRH}^{eff}}$$

$$n_Q = 2C_{area}k_B T / (q^2 d_{pero})$$

How to make sense out of it

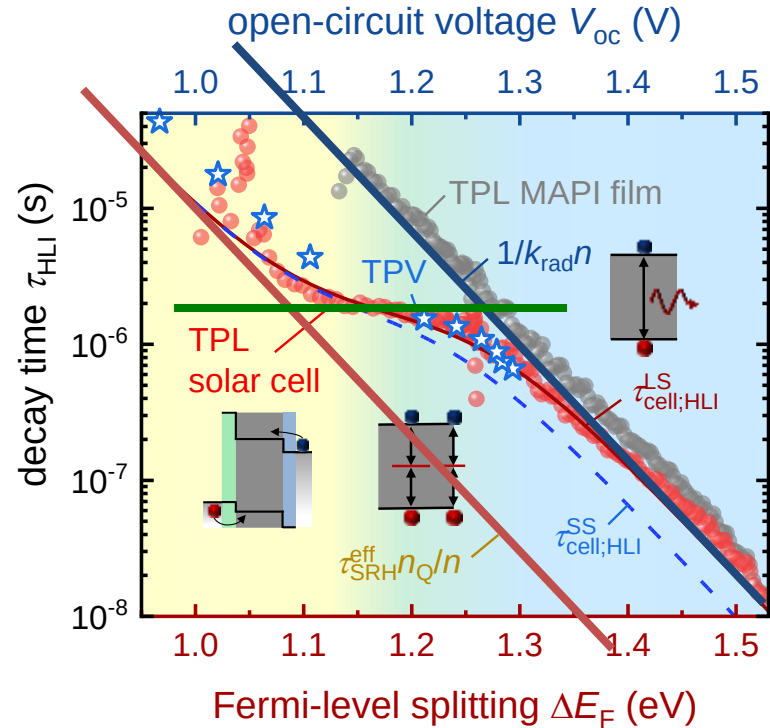


$$\frac{dn(t)}{dt} = -k_{rad}n(t)^2 - \frac{n(t)}{\tau_{SRH}^{bulk}} - \frac{C_{area}}{qd_{pero}} \frac{dV_{ext}(t)}{dt} + G$$

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$$n_Q = 2C_{area}k_B T / (q^2 d_{pero})$$

How to make sense out of it



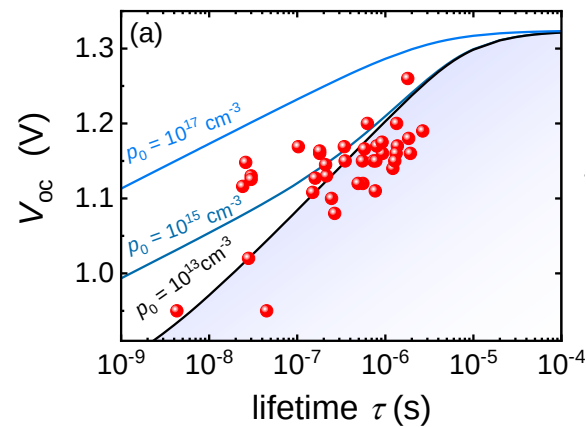
$$\frac{dn(t)}{dt} = -k_{rad}n(t)^2 - \frac{n(t)}{\tau_{SRH}^{bulk}} - \frac{C_{area}}{qd_{pero}} \frac{dV_{ext}(t)}{dt} + G$$

$$\tau_{cell, HLI}^{LS} = -\frac{n(t)}{dn(t)/dt} = \frac{n_Q/n(t)+1}{k_{rad}n(t)+1/\tau_{SRH}^{eff}}$$

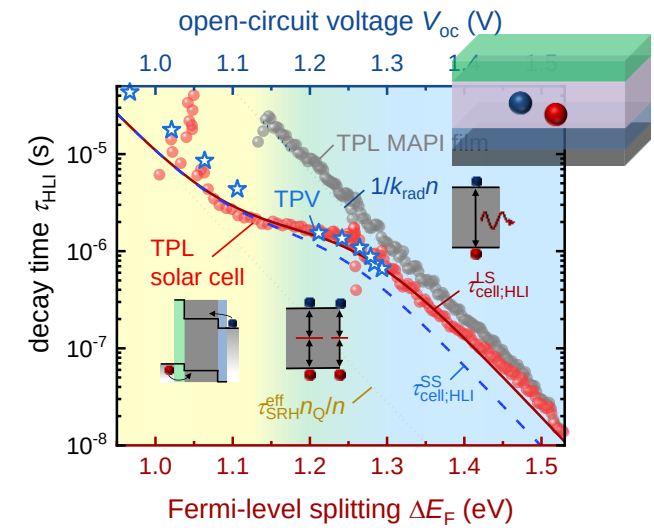
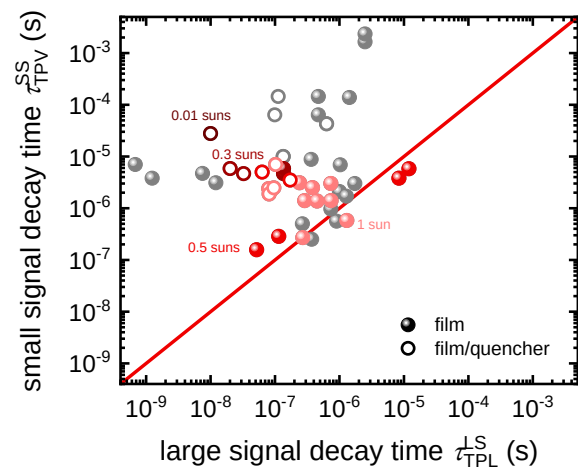
$$n_Q = 2C_{area} k_B T / (q^2 d_{pero})$$

Summary

- 1) “Lifetimes” correlate with V_{oc} but not in an easy way
- 2) “Lifetimes” are rarely constants



3) Huge method to method variation in “lifetimes” results from voltage dependence of decay times





Thanks to
Thomas Unold
Jose Marquez
Martin Stolterfoht
Helmholtz Association for Funding

Thank you for your attention

PROGRESS REPORT



Photoluminescence-Based Characterization of Halide Perovskites for Photovoltaics

Thomas Kirchartz, José A. Márquez, Martin Stollerfoht, and Thomas Unold**

FULL PAPER

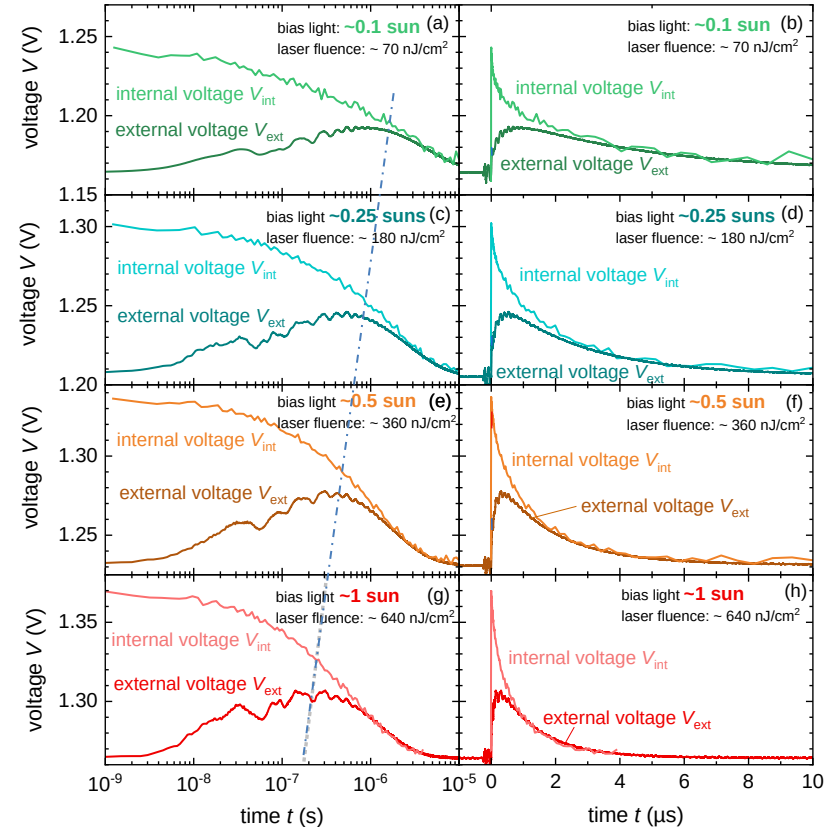
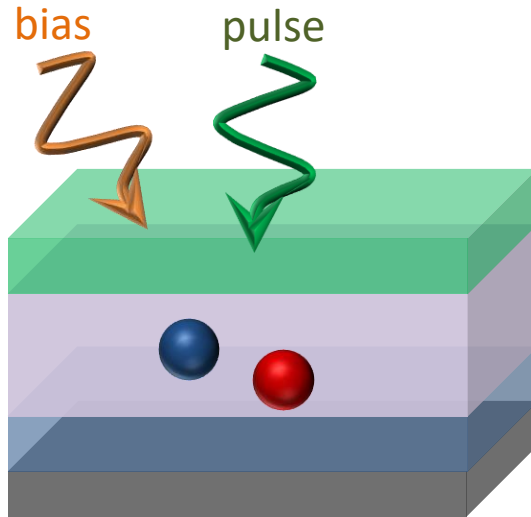


Understanding Transient Photoluminescence in Halide Perovskite Layer Stacks and Solar Cells

Lisa Krückemeier, Benedikt Krogmeier, Zhifa Liu, Uwe Rau, and Thomas Kirchartz**

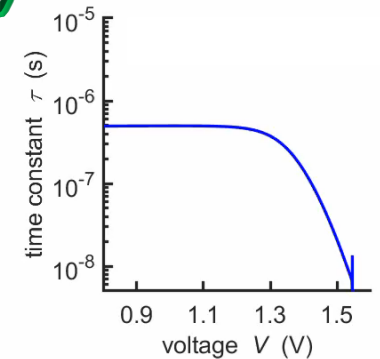
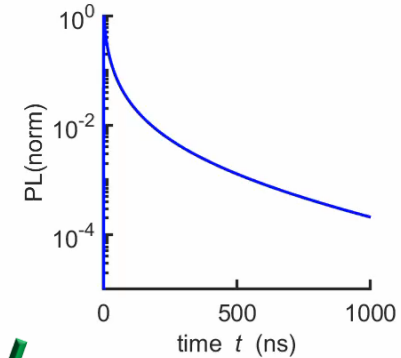
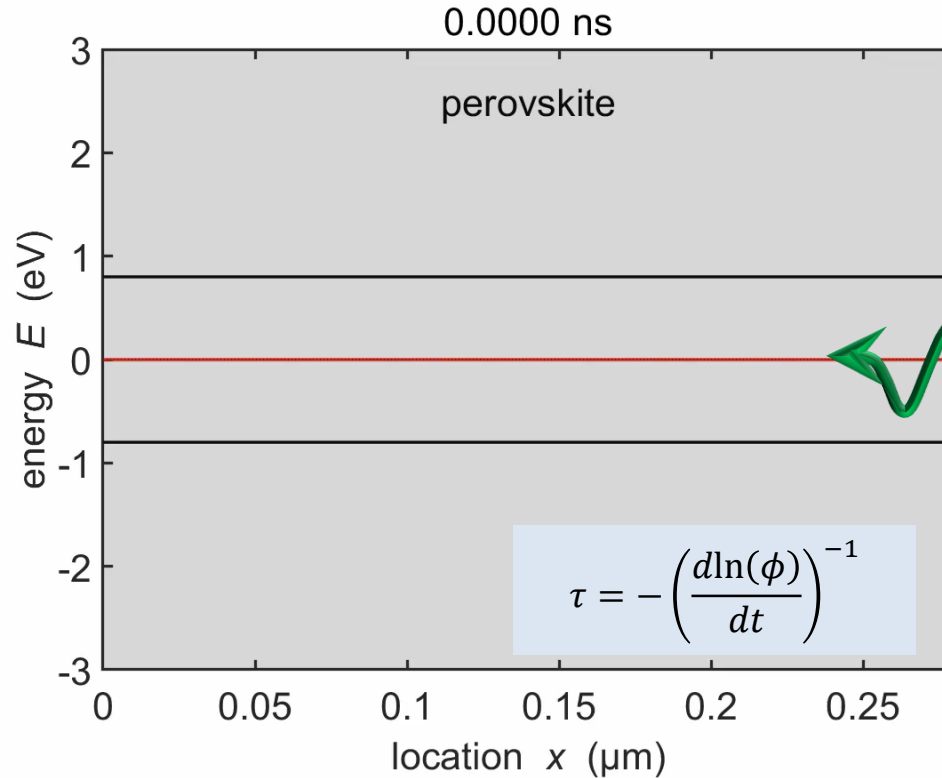
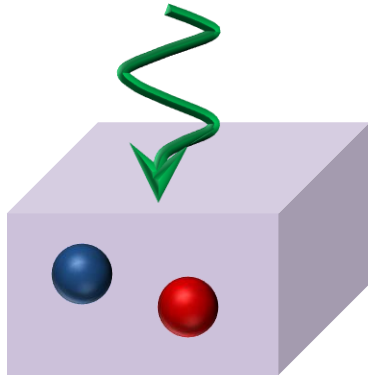
Useful literature on the contents of the talk

Experimental data – internal vs. external voltage



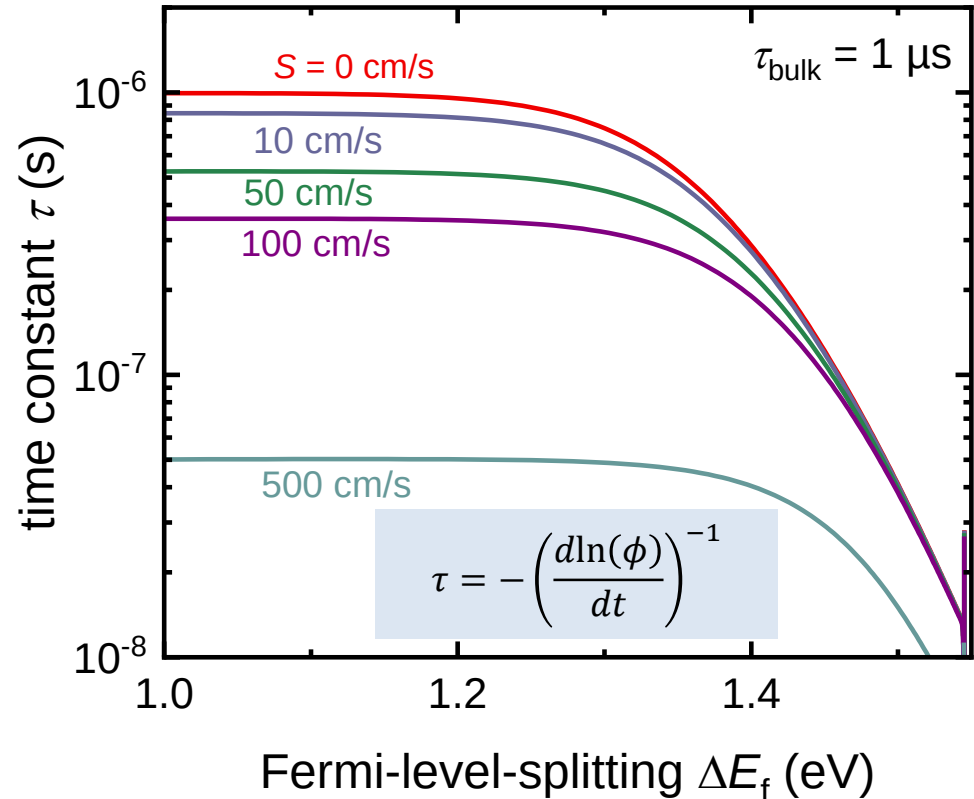
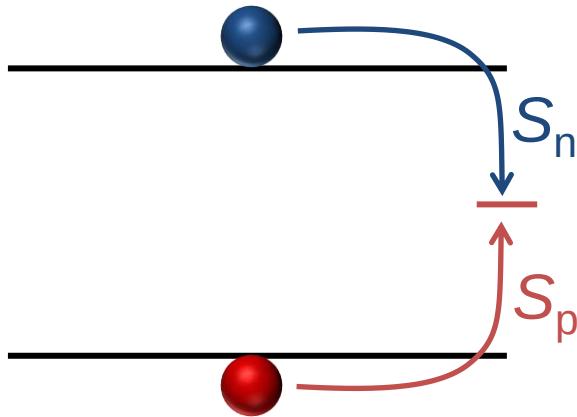
Transient Photoluminescence

Layer on glass - Video



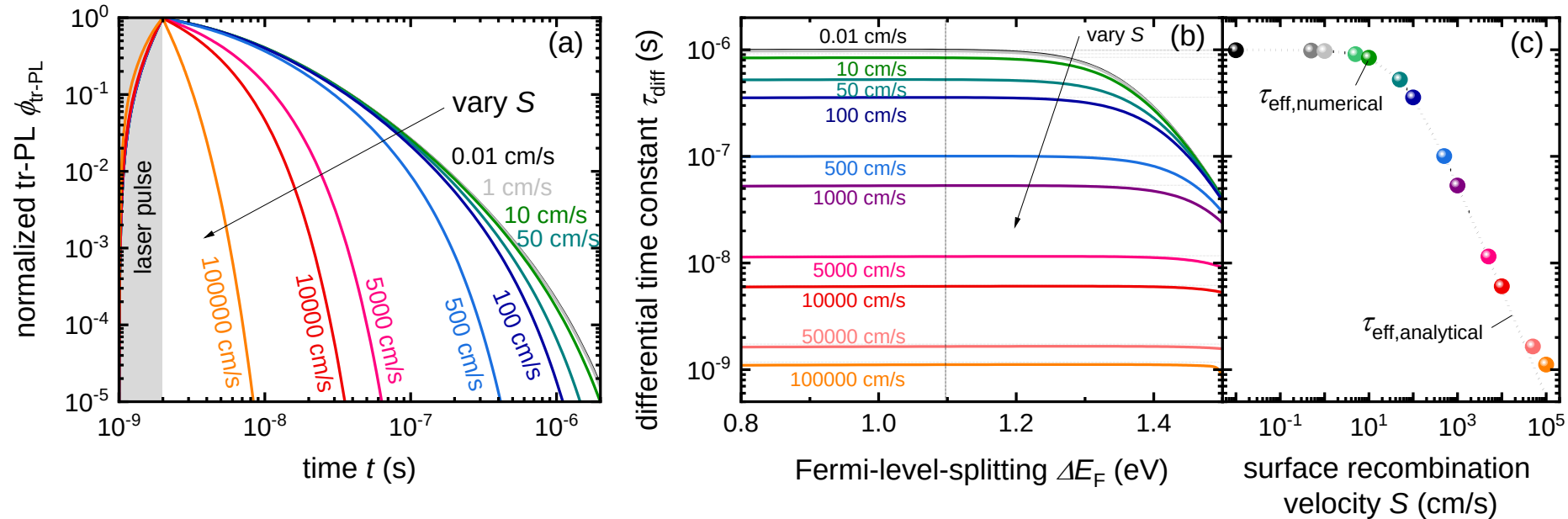
Transient Photoluminescence

Layer on glass – Surface recombination



Transient Photoluminescence

Layer on glass – Surface recombination



TPV Decay Constants

Experiment vs. Simulation

